

# IR ABSORPTION SPECTROSCOPY OF FLUOROCARBON MOLECULES IN A DBD

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## Abstract

IR diagnostics were performed in argon, nitrogen, dry air and admixtures of fluorocarbons. Fluorocarbons are usable to receive better hydrophobic properties of textile. In discharges in argon/nitrogen/(CF<sub>4</sub> or c-C<sub>4</sub>F<sub>8</sub>) mixtures CO, COF<sub>2</sub>, HF, C<sub>2</sub>F<sub>6</sub>, and C<sub>2</sub>F<sub>4</sub> molecules were found by applying IR absorption spectroscopy. In the case of discharges in argon/(CF<sub>4</sub> or C<sub>2</sub>F<sub>6</sub>) mixtures CF<sub>3</sub> radical was detected by means of emission spectroscopy.

## 1. Experimental set-up

The discharge is running in a cylindrical vessel (0.8 m diameter and 1.0 m long). For more details see our other report on this conference. The vessel can be evacuated to  $10^{-2}$  mbar and filled with various working gases (around 0.5 to 1.5 bar). The interelectrode gap is usually flooded with a continuous gas flow (various gases and their mixtures) of up to 7.5 l<sub>n</sub>/min at constant total pressure. The gas flow can be varied between 0.02 and 2 l<sub>n</sub>/min Ar, 0.05 and 5 l<sub>n</sub>/min for N<sub>2</sub>, 0.005 and 0.5 l<sub>n</sub>/min for admixture gases. The total pressure is kept constant controlled by a valve and monitored by pressure gauge.

## 2. IR- diagnostics in mixtures of N<sub>2</sub> or Ar with fluorocarbon

Concentrations of various species were measured end-on by Fourier Transform IR (FTIR) absorption spectroscopy. The optical absorption length is in the order of 70 cm. Absorbances in the range between  $10^{-2}$  and 1 could be measured. The absorbance is given by the relative change of the light intensity  $I_0$  due to absorption, i.e. by  $\Delta I/I_0$ . The detection of IR absorption spectra is a suitable method for the absolute density determination of different species in the gas discharge volume.

Nonthermal discharges in fluorocarbon molecules are very interesting subjects of investigations for some reasons. These molecules are used very often for industrial applications, for example plasma polymerization and plasma etching processes. Fluorocarbons are also known as a very fast quencher of charged particles by a fast attachment process. As a results of chemical reactions in fluorocarbon gases very active fluorine atoms and also radicals with fluorine atoms are produced. The diagnostics of fluorine atom, and radical densities depending on plasma processing parameters are a very important issue for understanding of plasma chemistry in discharges containing fluorocarbons. Optimization of the plasma polymerization process in nonthermal plasmas can be achieved by changing of gas composition and plasma parameters.

Identification of fluorine atom, and  $\text{CF}_x$ -radical densities are known by applying the emission spectroscopy and/or absorption spectroscopy in UV and visible ranges. The absolute  $\text{CF}_2$  radical density, for example, was measured in a fluorocarbon plasma by UV absorption spectroscopy [1]. As an alternative method the IR absorption spectroscopy method can be used. The absolute density of  $\text{CF}_x$  ( $x=1-3$ ) radicals was measured by applying very sensitive infrared diode laser absorption spectroscopy [2]. FTIR absorption spectroscopy is also available for this aim.

Fluorocarbons we used are: tetrafluoromethane ( $\text{CF}_4$ ), hexafluoroethane ( $\text{C}_2\text{F}_6$ ) and cyclo-octafluorobutane ( $\text{c-C}_4\text{F}_8$ ). As it was shown in [2] the  $\text{CF}_x$  radicals are the main dissociation products of fluorocarbons in an ECR plasma. The concentrations of  $\text{CF}_2^-$  and  $\text{CF}^-$  radicals are higher by two orders of magnitude in discharges with admixtures of  $\text{c-C}_4\text{F}_8$  compared to  $\text{CF}_4$ . The main product of  $\text{CF}_4$  dissociation is the  $\text{CF}_3^-$  radical. All mentioned  $\text{CF}_x^-$  radicals in an ECR plasma are important precursors of polymer deposition. Therefore it is important to study the influence of the C/F ratio of the fluorocarbons used on the radical densities and also the radical kinetics in high density plasmas.

Typical IR spectra of  $\text{Ar}/\text{CF}_4$ ,  $\text{N}_2/\text{CF}_4$  and  $\text{Ar}$  (or  $\text{N}_2$ , or air)/ $\text{c-C}_4\text{F}_8$  mixtures are shown in Figs. 1-3. In the figures not all the absorption bands are identified yet. We can identify  $\text{C}_2\text{F}_2$  ( $1030\text{ cm}^{-1}$ ),  $\text{C}_2\text{F}_6$  ( $1116\text{ cm}^{-1}$ ,  $\text{CF}_3^-$  radical production and further recombination), CO molecules, and HF (fine structure in the absorption spectra in the range of a  $3700\text{--}4200\text{ cm}^{-1}$ ) in a mixture of  $\text{N}_2/\text{CF}_4$ . After relatively long time of discharge duration (35 min) the absorption band near  $740\text{ cm}^{-1}$  was found. This band belongs to the "amorphous" polytetrafluoroethane (PTFE). As an accompanying product one can identify  $\text{H}_2\text{O}$  molecules (absorption in the range of a  $1400\text{--}2000\text{ cm}^{-1}$ ).

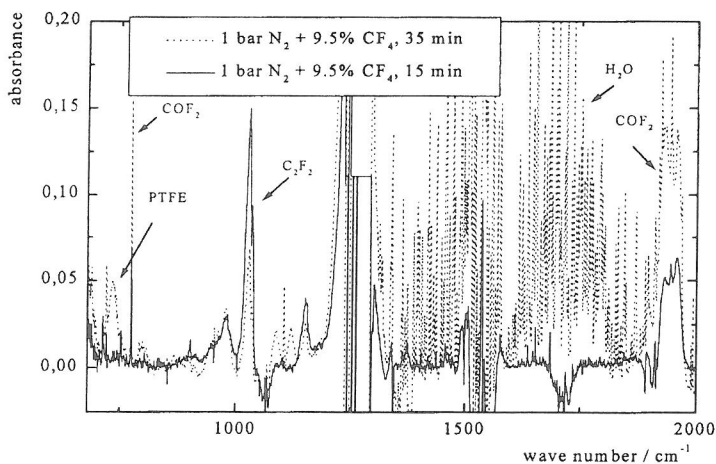


Fig.1: IR-absorption spectra in  $\text{N}_2/\text{CF}_4$ -mixtures.

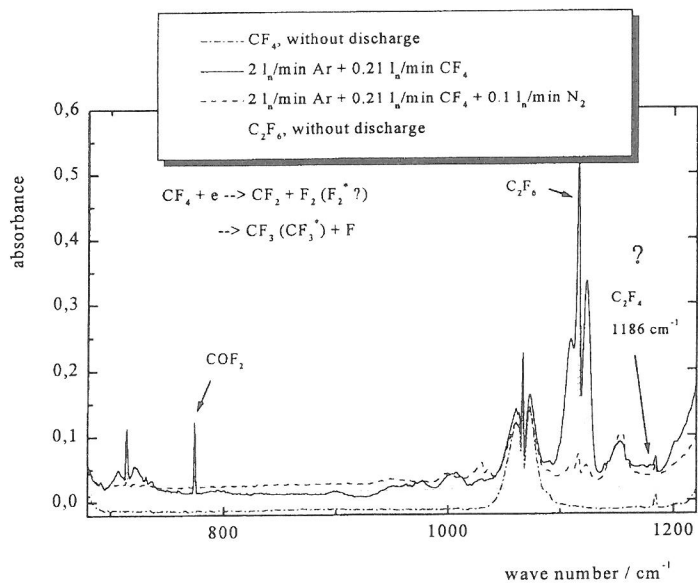


Fig 2: IR absorption spectra of Ar/ $\text{CF}_4$  mixtures.

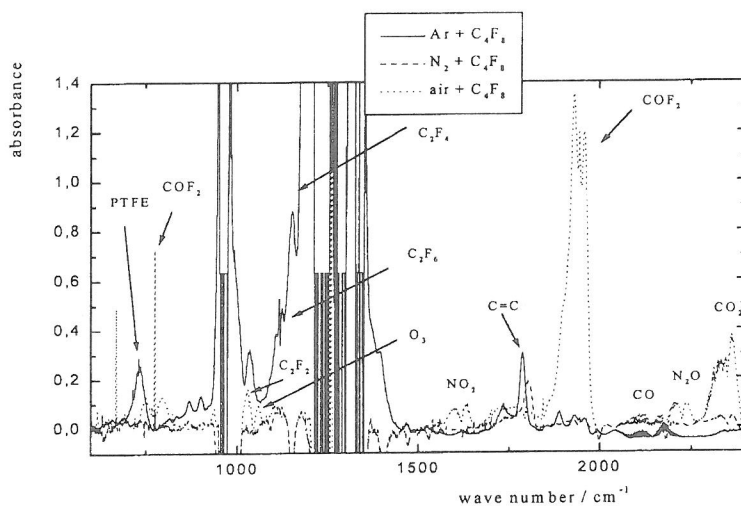


Fig. 3: IR absorption spectra in admixtures of  $0.1 \text{ l/min c-C}_4\text{F}_8$  to  $1 \text{ l/min Ar}$  (or  $\text{N}_2$ , or air).

Water came out of the electrode surfaces and surfaces nearby due to the increase of the gas temperature (electrode temperature also), because the discharge is running for a long time with high power.

In a  $c\text{-C}_4\text{F}_8$  discharge we detected following products: „amorphous” PTFE, CO,  $\text{C}_2\text{F}_6$ -molecules ( $1116\text{ cm}^{-1}$ , by  $\text{CF}_3$ - radical production and further recombination),  $\text{C}_2\text{F}_4$  molecules ( $1186\text{ cm}^{-1}$  by direct dissociation of  $c\text{-C}_4\text{F}_8$  and/or  $\text{CF}_2$ - radical production with further recombination [3]), and HF molecules. The densities of all mentioned products are increasing, if the discharge is running at a relatively high power and high  $c\text{-C}_4\text{F}_8$  concentration. The small amount of  $\text{COF}_2$  molecules as a product of these discharges could be also seen ( $774$ , and  $1944\text{ cm}^{-1}$  bands). This molecule was observed as main product in a synthetic air/ $c\text{-C}_4\text{F}_8$  mixture. In this mixture  $\text{NO}_2$ , CO,  $\text{CO}_2$ ,  $\text{O}_3$  and  $\text{N}_2\text{O}$  molecules are also seen.

By small admixture of nitrogen (only several percent in concentration) to Ar/  $\text{CF}_4$  mixture the intensity of the absorption band at  $1116\text{ cm}^{-1}$  ( $\text{C}_2\text{F}_6$ ) is strongly reduced. Simultaneously, the intensity of the emission band belonging to the  $\text{CF}_3$ - radical is also decreased. These results show that  $\text{CF}_3$ - radical is very fast quenched by chemical reaction with nitrogen (atoms, ions). Emission spectrum of  $\text{CF}_3$ - radical are shown on Figs. 4, 5. The very bright yellow emission (in the region  $450\text{-}750\text{ nm}$ ) which belongs to the  $\text{CF}_3$ - radical was found earlier by M. Suto [4].

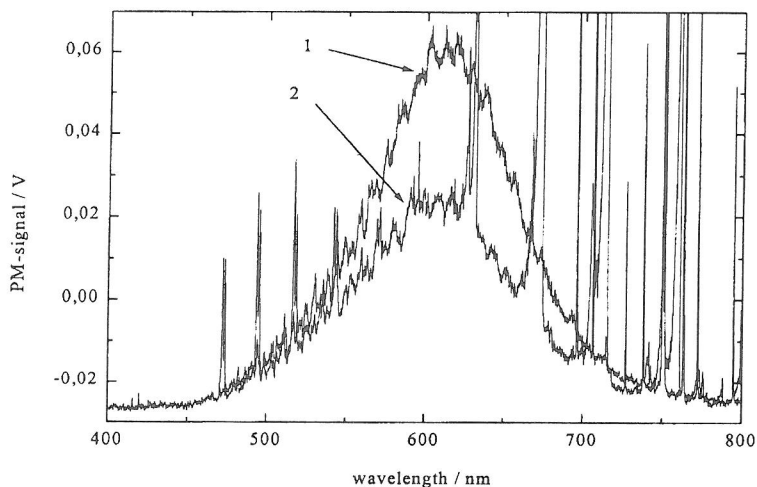


Fig. 4: Emission spectra of  $\text{CF}_3$ - radical, depending on  $\text{N}_2$  concentration;  $2\text{ l}_N/\text{min Ar} + 0.21\text{ l}_N/\text{min CF}_4$ ,  $p = 1\text{ bar}$ . 1- without  $\text{N}_2$ , 2-  $0.08\text{ l}_N/\text{min N}_2$ .

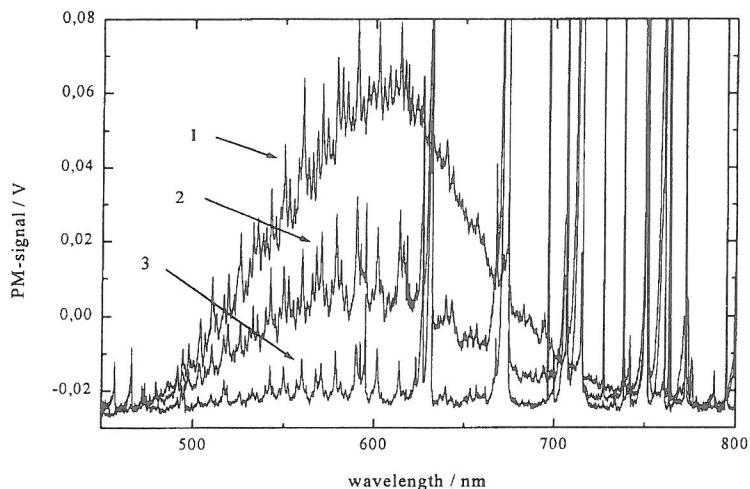


Fig. 5: Emission spectra of  $CF_3$ - radical, depending on the  $N_2$  concentration;  $1l_r/min$   $Ar + 0.12l_r/min$   $C_2F_6$ ,  $p = 1bar$ . 1- without  $N_2$ , 2-  $0.1l_r/min$   $N_2$ , 3-  $0.2l_r/min$   $N_2$ .

## References

- [1] J. Both, G. Cunge, F. Neuilly and N. Sadeghi, PSST 7 (1998) 423-430.
- [2] K. Miyata, M. Hori and T. Goto, Jpn. J.Appl.Phys 36 (1997) 5340-5345.
- [3] P. Chowdhury, K. Rama Rao, and J. P. Mittal, J. Phys. Chem., 90 (1986) 2877-2882.
- [4] M. Suto and N. Washida, J.Chem.Phys., 78 (1983) 1007-1011.

